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	TRADEM		· · · · · · ·	U.S. PATENT DOCUMENTS	T	<b>.</b>	<u> </u>	
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing	Date
M	AA	3,800,792	04/02/74	McKnight et al.	128	156	04/17/72	
£2_	AB	4,749,572	06/07/88	Ahari	424	132	08/21/85	
<u> </u>	AC	4,803,066	02/07/89	Edwards	424	132	03/18/87	
1	AD	4,828,832	05/09/89	De Cuellar et al.	424	618	02/26/87	
	AE	4,952,411	08/28/90	Fox, Jr. et al.	424	618	10/18/88	
	AF	5,454,886	10/03/95	Burrell et al.	148	565	11/18/93	
12_	AG	5,744,151	04/28/98	Capelli	424	405	06/27/96	
4	АН	5,770,255	06/23/98	Burrell et al.	427	2.1	09/29/93	
	AI	5,792,793	08/11/98	Oda et al.	514	495	10/07/94	
	AJ	5,945,032	08/31/99	Breitenbach et al.	252	186.29	09/23/97	
	AK	6,022,547	02/08/00	Herb et al.	424	401	06/28/96	·
	AL	6,071,541	06/06/00	Murad	424	616	06/11/99	
/h_	АМ	6,071,543	06/06/00	Thornfeldt	424	642	06/01/98	
				FOREIGN PATENT DOCUMENTS				
Examiner Initial		Document Number	Date	Country	Class	Subclass	Transl Yes	lation No
M	AN	WO 93/23092	25/11/93	PCT	A61L	29/00		
<i>m</i> ,	AO	WO 95/13704	26/05/95	PCT	A01N	59/16		_
1	AP	W0 98/41095	24/09/98	РСТ	A01N	59/00		
m	AQ	EP 0355009 A1	21/02/90	Europe	A61K	31/635		
2	AR	EP 0 254 413	27/01/88	Europe	A 61 K	33/38		
12	AS	EP 0599188 A1	01/06/94	Europe	A61K	31/20		
m	AT	EP 0378147 A2	18/07/90	Europe	A61K	7/48		
	AU	EP 0136768 A2	10/04/85	Europe	A 61 K	33/38		-
	AV	022309	06/12/90	Italy	ANTK		Yes	
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\*Examiner:

Date Considered

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Coatings, J. Vac. Sci. Technol., Vol. 11(4), 666-670, 1974.

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PATENT AND TRADEMARK OFFICE 53-0							09/840,637	1637
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2.	AA	CN 1262093	9/8/00	China	A 61 K	7/02	abstract	
	AB	CN 1082645	23/2/94	China	D 06 M	11/83	abstract	-
	AC	GB 965,010	29/07/64	Great Britain	CO1 6,9			
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	<u> </u>		OTHER DOCUMEN	NTS (Including Author, Title, Date, P	artinent Pages 5	itc )		
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U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 14072-010001

Application No. 09/840,637

## **Information Disclosure Statement** by Applicant

(Use several sheets if necessary)

Burrell et al

Applicant

**Group Art Unit** 

(37 CFR §1.98(b))

Filing Date April 23, 2001 1616

		_		nt Documents			1 8
Examiner Initjal	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Appropriat
DD -	AA	2002/0045049	04/18/02	Madsen			111
	AB	6,365,130	04/02/02	Barry et al.			0 8
	AC	2002/0016585	02/07/02	Sachse			
	AD	2002/0001628	01/03/02	Ito			
	AE	6,277,169	08/21/01	Hampden-Smith et al.			
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	AG	6,201,164	03/13/01	Wulff et al.			
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	AN	6,010,478	01/04/00	Bellhouse et al.			
	AO	5,981,822	11/09/99	Addison			
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	AV	5,534,288	07/09/96	Gruskin et al.			
	AW	5,520,639	05/28/96	Peterson et al.			
	AX	5,457,015	10/10/95	Boston			
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	AZ	5,399,163	03/21/95	Peterson et al.			
M	AAA	5,383,851	01/24/95	McKinnon, Jr. et al.			

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Date Considered

2004 EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute	Form	PT	0-1	449
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U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. Application No. 14072-010001 09/840,637

## **Information Disclosure Statement by Applicant** (Use several sheets if necessary)

(37 CFR §1.98(b))

Applicant Burrell et al Filing Date Group Art Unit April 23, 2001 1616

			U.S. Pate	nt Documents		<del>"</del>	
Examiner	Desig.	Document	Publication				Filing Date
Initial	ID	Number	Date	Patentee	Class	Subclass	If Appropriate
	ABB	5,372,589	12/13/94	Davis			
901	ACC	5,369,155	11/29/94	Asmus			
	ADD	Des. 349,958	08/23/94	Hollis et al.			
	AEE	5,312,335	05/17/94	McKinnon et al.			
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	AGG	5,236,421	08/17/93	Becher	1		
	АНН	5,143,717	09/01/92	Davis			
	AII	5,064,413	11/12/91	McKinnon et al.			
	AJJ	5,019,096	05/28/91	Fox, Jr. et al.			
	AKK	4,960,413	10/02/90	Sagar et al.			
	ALL	4,847,049	07/11/89	Yamamoto			
*	AMM	4,790,824	12/13/88	Morrow et al.			
	ANN	4,633,863	01/06/87	Filips et al.			
	AOO	4,596,556	06/24/86	Morrow et al.			
	APP	4,581,028	04/08/86	Fox, Jr. et al.			
	AQQ	4,476,590	10/16/84	Scales et al.			
	ARR	4,355,636	10/26/82	Oetjen et al.			
	ASS	4,324,237	04/13/82	Buttaravoli			
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Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AWW	02/44625	06/06/02	WIPO				
M	AXX	02/18003	03/07/02	WIPO				
	AYY	02/15698	02/28/02	WIPO				

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Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 14072-010001

Application No. 09/840,637

Information Disclosure Statement
by Applicant
(Use several sheets if necessary)

Applicant
Burrell et al

April 23, 2001

Filing Date

Group Art Unit

(37 CFR §1.98(b))

Foreign Patent Documents or Published Foreign Patent Applications Document **Publication** Examiner Desia. Country or Trans Initial ID Number Date **Patent Office** Class **Subclass** Yes **AZZ** CN1328819 01/02/02 CN (full document) CN1328819 01/02/02 AAAA CN (abstract only) X X ABBB CN1328827 01/02/02 CN (full document) 01/02/02 X ACCC CN1328827 CN (abstract only) **ADDD** 1 159 972 12/05/01 EP **AEEE** CN1322474 11/21/01 X CN (full document) AFFF CN1322474 11/21/01 X CN (abstract only) **AGGG** CN1322874 11/21/01 CN (full document) X **AHHH** CN1322874 11/21/01 CN (abstract only) X WIPO AIII 01/74300 10/11/01 AJJJ 01/70052 09/27/01 **WIPO** AKKK X CN1306117 08/01/01 CN (full document) **ALLL** CN1306117 08/01/01 CN (abstract only) X **AMMM** 01/43788 **WIPO** 06/21/01 **ANNN** 01/41819 **WIPO** 06/14/01 A000 01/41774 06/14/01 **WIPO** APPP 01/34686 **WIPO** 05/17/01 **AQQQ** 01/27365 04/19/01 WIPO ARRR CN1291666 04/18/01 CN (full document) X ASSS CN1291666 04/18/01 CN (abstract only)  $\mathbf{X}$ Á ATTT X CN1291667 04/18/01 CN (full document) AUUU CN1291667 04/18/01  $\mathbf{X}$ CN (abstract only) **AVVV** 01/24839 04/12/01 **WIPO AWWW** 01/15710 03/08/01 WIPO AXXX CN1279222 01/10/01 CN (full document) X **AYYY** CN1279222 01/10/01 CN (abstract only) X

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attomey's Docket No. 14072-010001	Application No. / 09/840,637		
	closure Statement oplicant	Applicant Burrell et al			
(Use several sheets if necessary)		Filing Date April 23 2001	Group Art Unit		

Examiner	Desig.	Document	Publication	Country or		·	Tran	abatio
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M1	AAAAA	00/64506	11/02/00	WIPO			O.	1
1	ABBBB	00/44414	08/03/00	WIPO				
	ACCCC	00/30697	06/02/00	WIPO				
	ADDDD	CN1241662	01/19/00	CN (full document)				X
1	AEEEE	CN1241662	01/19/00	CN (abstract only)			X	
	AFFFF	2,242,033	01/03/99	CA				
	AGGGG	98/51273	11/19/98	WIPO				
	АНННН	0780138	06/25/97	EP				
	AIIII	92/13491	08/20/92	WIPO				
	AJJJJ	0 378 147	07/18/90	EP				
	AKKKK	3807944	09/21/89	DE (full document)				X
	ALLLL	3807944	09/21/89	DE (abstract only)			Х	
	AMMMM	0 356 060	08/07/89	EP				
	ANNNN	87/07251	12/03/87	WIPO			·	
	A0000	60-21912	02/04/85	JP (full document)				X
	APPPP	60-21912	02/04/85	JP (abstract only)			Х	
	AQQQQ	Sho 58- 126910	02/04/85	JP (full document)				Х
	ARRRR	Sho 58- 126910	02/04/85	JP (abstract only)			х	
	ASSSS	2 140 684	12/05/84	UK				
	ATTTT	2 073 024	10/14/81	UK				
	AUUUU	2748882	05/03/79	DE (full document)				Х
	AVVVV	2748882	05/03/79	DE (abstract only)			Х	
Ţ	AWWWW	427,106	4/16/35	UK				
m	AXXXX	420,052	11/23/34	UK		1		1

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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					

		Attorney's Docket No. 14072-010001	Application No. 09/840,637	
Information Disclosure Statement by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Burrell et al		
		Filing Date April 23, 2001	Group Art Unit 1616	

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Do	AYYYY	Shigemasa et al., "Applications of Chitin and Chitosan for Biomaterials" Biotechnology & Genetic Engineering Reviews Vol. 13 (14) pp. 383-420 (DATE UNAVAILABLE),		
	AZZZZ	Thomston "Danasition Taskuslanias for Films and Castiness Castine Danasition for Contamina"		

Examiner Signature

**Date Considered** 

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 14072-010001	Application No. 09/840,637 /	_	
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Burrell et al			
		Filing Date April 23, 2001	Group Art Unit 1614		
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				nt Documents			Filing Date
Examiner Initial	Desig.	Document Number	Publication Date	Patentee	Class	Subclass	If Appropriate
	AA	2002/0192298 A1	12/19/02	Burrell et al.	1		
1	AB	2002/0051824 A1	05/02/02	Burrell et al.		_	
	AC	6,333,093	12/25/01	Burrell et al.			
	AD	6,238,686	05/29/01	Burrell et al.		·	
	AE	6,017,553	01/25/00	Burrell et al.			
	AF	5,985,308	11/16/99	Burrell et al.			
	AG	5,958,440	09/28/99	Burrell et al.			
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	AI ·	5,837,275	11/17/98	Burrell et al.			
	AJ	5,770,258	06/23/98	Takizawa ,			
	AK	5,753,251	05/19/98	Burrell et al.			
	AL	5,681,575	10/28/97	Burrell et al.	_   _		
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	AN	02/09729	02/07/02	WIPO						
	AO	01/80920	11/01/01	WIPO						<u> </u>
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	AQ	01/49301	07/12/01	WIPO					<b>_</b>	
	AR	2000327578	11/28/00	JP (full document)		<u> </u>				X
+ ,	AS	2000327578	11/28/00	JP (abstract only)					X	<del> </del>
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	AU	0 328 421 A2	08/16/99	EP		_			<b> </b>	
	AV	11124335	05/11/99	JP (full document)		<u> </u>	<u> </u>	<u> </u>		X
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Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Burrell et al		
		Filing Date April 23, 2001	Group Art Unit 1614	

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L			ID	Number	Date	Patent Office	Class	Subclass	Yes	No
ł		<u>/ I</u>	AY	11116488	04/27/99	JP (abstract only)			Х	
Ī		1	AZ	11060493	03/02/99	JP (full document)			' ,	x
		7 1	AAA	11060493	03/02/99	JP (abstract only)			x	
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	O,	<del>)</del> ;	AEE	93/23092	11/25/93	WIPO				

Other Documents (include Author, Title, Date, and Place of Publication)								
Examiner	Desig.							
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<b>A</b> )	AFF	Sant et al., "Morphology of Novel Antimicrobial Silver Films Deposited By Magnetron Sputtering Scripta Materiala, Vol. 41, No. 12, pp. 1333-1339, November 19, 1999						

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